

Application/Control No.

10/021,000

Applicant(s)/Patent under Reexamination

TAKESHITA, NOBUO

Art Unit

2627

Examiner Kim-Kwok CHU

		-		ISSUE	CL	AS	SIF	ICAT	TION						
		INTERNATIONAL CLASSIFICATION													
	CLASS		SUBCLASS				CI	AIMED		NON-CLAIMED					
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CROSS REFERENCES														1	
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Kim-Kv (Assis	Examiner) (Date)					O.G. Print Claim(s)			O.G. Print Fig.						
((Legal Instruments Examiner) (Date)															1
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